Searcn Notes			

Application/Control No.	lo. Applicant(s)/Patent under Reexamination	
10/724,768	KIM ET AL.	
Examiner	Art Unit	
Filip Zec	3744	

SEARCHED			
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Class	Subclass	Date	Examiner
62	404-408 187	6/12/2005	FZ
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
62	408	6/12/2005	FZ
62	404-407	6/12/2005	FZ
62	187	6/12/2005	FZ

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR		
Updated EAST search	6/12/2005	FZ		
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